

FORM PTO-1449	Atty. Docket No.: I69.12-0432	Application No.: 09/619,738
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT	First Named Inventor: Victor B. Sapozhnikov	
	Filing Date: July 19, 2000	Group Art:

U.S. PATENT DOCUMENTS

Examiner Initial	Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
<i>mm</i>	AA	6,015,632	01/18/00	Chambliss et al.	428	692
<i>mm</i>	AB	5,858,455	01/12/99	Chambliss et al.	427	131
<i>mm</i>	AC	5,849,400	12/15/98	Hiramoto et al.	428	213
<i>mm</i>	AD	5,733,427	03/31/427	Satou et al.	204	298.13
<i>mm</i>	AE	5,432,012	07/11/95	Lal et al.	428	610
	AF					
	AG					
	AH					
	AI					
	AJ					
	AK					

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

<i>mm</i>	AO	✓	"Spontaneous Lateral Composition Modulation in III-V Semiconductor Alloys", by J. Mirecki Millunchick et al. <u>MRS Bulletin</u> , July 1997, PP 28-43.
<i>mm</i>	AP	✓	"Magnetostatic Modes of Lateral-Magnetic-Superlattice Films in a Transverse field", by X. Wang et al., <u>J. Phys.: Condens. Matter</u> 9 (1997), PP 5777-5787, © 1997 JOP Publishing Ltd. (no month)
<i>mm</i>	AQ	✓	"Strain-dependent Morphology of Spontaneous Lateral Composition Modulations in (AIAs) _m (InAs) _n Short-Period Superlattices Grown by Molecular Beam Epitaxy" by A.G. Norman et al., <u>Applied Physics Letters</u> , Volume 73, Number 13, 28 September 1998, ©1998 American Institute of Physics.
<i>mm</i>	AR	✓	"Solid State Spectroscopy: Composition Modulation in Semiconductor Alloys and Superlattices" by the Solid State Spectroscopy Team at the National Renewable Energy Laboratory, <u>Research Topics at the Solid State Spectroscopy Laboratory at the National Renewable Energy Laboratory</u> , www.nrel.gov/sss/research.html . (no date)
<i>mm</i>	AS	✓	"Composition Modulation in AIAs/InAs Short Period Superlattices" by J. Mirecki Millunchick et al., Physical and Chemical Sciences Center Research Briefs, www.sandia.gov/1100/97resbrief/1rbrfhome.htm (1997). (no month)

EXAMINER:

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DATE CONSIDERED:

10/8/02

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.